Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/642,259	LEE ET AL.
Examiner	Art Unit
Jaison Joseph	2611

SEARCHED				
Class	Subclass	Date	Examiner	
375	375, 376	3/29/2007	IJ	
375	354, 355	3/29/2007	JJ	
375	371, 373	3/29/2007	IJ	
375	374	3/29/2007	JJ	
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
Inventor Search	3/29/2007	IJ
East	3/29/2007	IJ